#### **Features**

- 2.7V to 3.6V Supply
  - Full Read and Write Operation
- **Low Power Dissipation** 
  - 8 mA Active Current
  - 50 μA CMOS Standby Current
- Read Access Time 300 ns
- Byte Write 3 ms
- **Direct Microprocessor Control** 
  - DATA Polling
  - READY/BUSY Open Drain Output
- High Reliability CMOS Technology
  - Endurance: 100,000 Cycles
  - Data Retention: 10 Years
- JEDEC Approved Byte-Wide Pinout
- Commercial and Industrial Temperature Ranges

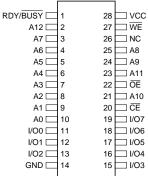
#### **Description**

The AT28BV64 is a low-voltage, low-power Electrically Erasable and Programmable Read Only Memory specifically designed for battery powered applications. Its 64K of memory is organized 8,192 words by 8 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 200 ns with power dissipation less than 30 mW. When the device is deselected the standby current is less than 50 μA. (continued)

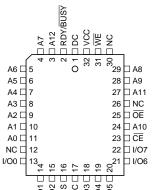
### **Pin Configurations**

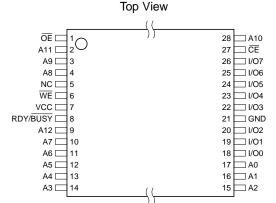
| Pin Name    | Function            |
|-------------|---------------------|
| A0 - A12    | Addresses           |
| CE          | Chip Enable         |
| ŌE          | Output Enable       |
| WE          | Write Enable        |
| I/O0 - I/O7 | Data Inputs/Outputs |
| RDY/BUSY    | Ready/Busy Output   |
| NC          | No Connect          |
| DC          | Don't Connect       |











**TSOP** 



64K (8K x 8) Battery-Voltage<sup>™</sup> **Parallel EEPROMs** 

**AT28BV64** 

Rev. 0493A-10/98



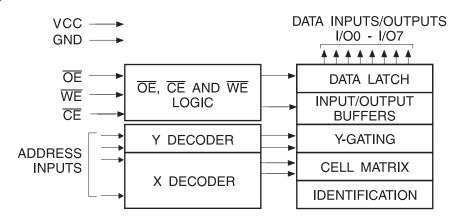


The AT28BV64 is accessed like a Static RAM for the read or write cycles without the need for external components. During a byte write, the address and data are latched internally, freeing the microprocessor address and data bus for other operations. Following the initiation of a write cycle, the device will go to a busy state and automatically clear and write the latched data using an internal control timer. The device includes two methods for detecting the end of a write cycle, level detection of RDY/BUSY and DATA polling

of I/O<sub>7</sub>. Once the end of a write cycle has been detected, a new access for a read or write can begin.

Atmel's 28BV64 has additional features to ensure high quality and manufacturability. The device utilizes error correction internally for extended endurance and for improved data retention characteristics. An extra 32-bytes of EEPROM are available for device identification or tracking.

#### **Block Diagram**



## **Absolute Maximum Ratings\***

| Temperature Under Bias55°C   | C to +125°C            |
|--|------------------------|
| Storage Temperature65°C  | C to +150°C            |
| All Input Voltages (including NC Pins) with Respect to Ground0.6   | V to +6.25V            |
| All Output Voltages with Respect to Ground0.6V to                  | V <sub>CC</sub> + 0.6V |
| Voltage on $\overline{\text{OE}}$ and A9 with Respect to Ground0.6 | V to +13.5V            |

\*NOTICE:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

#### **Device Operation**

**READ:** The AT28BV64 is accessed like a Static RAM. When  $\overline{CE}$  and  $\overline{OE}$  are low and  $\overline{WE}$  is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in a high impedance state whenever  $\overline{CE}$  or  $\overline{OE}$  is high. This dual line control gives designers increased flexibility in preventing bus contention.

BYTE WRITE: Writing data into the AT28BV64 is similar to writing into a Static RAM. A low pulse on the  $\overline{\text{WE}}$  or  $\overline{\text{CE}}$  input with  $\overline{\text{OE}}$  high and  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  low (respectively) initiates a byte write. The address location is latched on the falling edge of  $\overline{\text{WE}}$  (or  $\overline{\text{CE}}$ ); the new data is latched on the rising edge. Internally, the device performs a self-clear before write. Once a byte write has been started, it will automatically time itself to completion. Once a programming operation has been initiated and for the duration of  $t_{\text{WC}}$ , a read operation will effectively be a polling operation.

**READY/BUSY:** Pin 1 is an open drain READY/BUSY output that can be used to detect the end of a write cycle.

RDY/BUSY is actively pulled low during the write cycle and is released at the completion of the write. The open drain connection allows for OR-tying of several devices to the same RDY/BUSY line.

 $\overline{\text{DATA}}$  **POLLING:** The AT28BV64 provides  $\overline{\text{DATA}}$  POLLING to signal the completion of a write cycle. During a write cycle, an attempted read of the data being written results in the complement of that data for I/O<sub>7</sub> (the other outputs are indeterminate). When the write cycle is finished, true data appears on all outputs.

**WRITE PROTECTION:** Inadvertent writes to the device are protected against in the following ways: (a)  $V_{CC}$  sense—if  $V_{CC}$  is below 1.8V (typical) the write function is inhibited; (b)  $V_{CC}$  power on delay—once  $V_{CC}$  has reached 2.0V the device will automatically time out 10 ms (typical) before allowing a byte write; and (c) Write Inhibit—holding any one of  $\overline{OE}$  low,  $\overline{CE}$  high or  $\overline{WE}$  high inhibits byte write cycles.





## **DC and AC Operating Range**

|                                 |      | AT28BV64-30  |
|---------------------------------|------|--------------|
| Operating<br>Temperature (Case) | Com. | 0°C - 70°C   |
|                                 | Ind. | -40°C - 85°C |
| V <sub>CC</sub> Power Supply    |      | 2.7V to 3.6V |

## **Operating Modes**

| Mode                  | CE              | ŌĒ               | WE              | I/O              |
|-----------------------|-----------------|------------------|-----------------|------------------|
| Read                  | V <sub>IL</sub> | V <sub>IL</sub>  | V <sub>IH</sub> | D <sub>OUT</sub> |
| Write <sup>(2)</sup>  | V <sub>IL</sub> | V <sub>IH</sub>  | V <sub>IL</sub> | D <sub>IN</sub>  |
| Standby/Write Inhibit | V <sub>IH</sub> | X <sup>(1)</sup> | X               | High Z           |
| Write Inhibit         | X               | Х                | V <sub>IH</sub> |                  |
| Write Inhibit         | X               | V <sub>IL</sub>  | X               |                  |
| Output Disable        | X               | V <sub>IH</sub>  | X               | High Z           |

Notes: 1. X can be  $V_{IL}$  or  $V_{IH}$ .

2. Refer to AC Programming Waveforms.

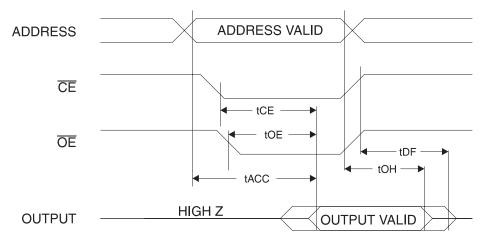
### **DC Characteristics**

| Symbol                             | Parameter                            | Condition  | Min | Max | Units |
|------------------------------------|--------------------------------------|--|-----|-----|-------|
| ILI                                | Input Load Current                   | $V_{IN} = 0V$ to $V_{CC} + 1.0V$   |     | 5   | μΑ    |
| I <sub>LO</sub>                    | Output Leakage Current               | $V_{I/O} = 0V \text{ to } V_{CC}$  |     | 5   | μΑ    |
| I <sub>SB</sub>                    | V <sub>CC</sub> Standby Current CMOS | $\overline{\text{CE}} = \text{V}_{\text{CC}} - 0.3 \text{V to V}_{\text{CC}} + 1.0 \text{V}$ |     | 50  | μΑ    |
| I <sub>cc</sub>                    | V <sub>CC</sub> Active Current AC    | $f = 5 \text{ MHz}; I_{OUT} = 0 \text{ mA}; CE = V_{IL}$                                     |     | 8   | mA    |
| V <sub>IL</sub>                    | Input Low Voltage                    |  |     | 0.6 | V     |
| V <sub>IH</sub>                    | Input High Voltage                   |  | 2.0 |     | V     |
| \ <i>I</i>                         | Outrot Low Valtage                   | I <sub>OL</sub> = 1 mA   |     | 0.3 | V     |
| V <sub>OL</sub> Output Low Voltage | Output Low voltage                   | $I_{OL} = 2 \text{ mA for RDY/}\overline{BUSY}$  |     | 0.3 | V     |
| V <sub>OH</sub>                    | Output High Voltage                  | I <sub>OH</sub> = -100 μA  | 2.0 |     | V     |

#### **AC Read Characteristics**

|                                   |  | AT28E |     |       |
|-----------------------------------|--|-------|-----|-------|
| Symbol                            | Parameter  | Min   | Max | Units |
| t <sub>ACC</sub>                  | Address to Output Delay                                      |       | 300 | ns    |
| t <sub>CE</sub> <sup>(1)</sup>    | CE to Output Delay   |       | 300 | ns    |
| t <sub>OE</sub> <sup>(2)</sup>    | OE to Output Delay   | 0     | 150 | ns    |
| t <sub>DF</sub> <sup>(3)(4)</sup> | CE or OE High to Output Float                                | 0     | 60  | ns    |
| t <sub>OH</sub>                   | Output Hold from OE, CE or Address, whichever occurred first | 0     |     | ns    |

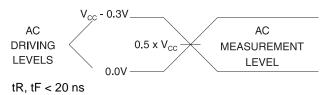
## AC Read Waveforms<sup>(1)(2)(3)(4)</sup>



Notes: 1.  $\overline{\text{CE}}$  may be delayed up to  $t_{\text{ACC}}$  -  $t_{\text{CE}}$  after the address transition without impact on  $t_{\text{ACC}}$ .

- 2.  $\overline{\text{OE}}$  may be delayed up to  $t_{\text{CE}}$   $t_{\text{OE}}$  after the falling edge of  $\overline{\text{CE}}$  without impact on  $t_{\text{CE}}$  or by  $t_{\text{ACC}}$   $t_{\text{OE}}$  after an address change without impact on  $t_{\text{ACC}}$ .
- 3.  $t_{DF}$  is specified from  $\overline{OE}$  or  $\overline{CE}$  whichever occurs first ( $C_L = 5 \text{ pF}$ ).
- 4. This parameter is characterized and is not 100% tested.

# Input Test Waveforms and Measurement Level



## **Output Test Load**

## **Pin Capacitance**

 $f = 1 \text{ MHz}, T = 25^{\circ}C^{(1)}$ 

| Symbol           | Тур | Max | Units | Conditions            |
|------------------|-----|-----|-------|-----------------------|
| C <sub>IN</sub>  | 4   | 6   | pF    | $V_{IN} = 0V$         |
| C <sub>OUT</sub> | 8   | 12  | pF    | V <sub>OUT</sub> = 0V |

Note: 1. This parameter is characterized and is not 100% tested.



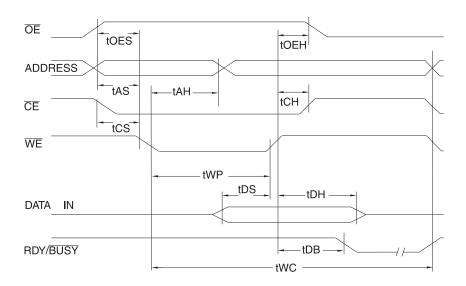


### **AC Write Characteristics**

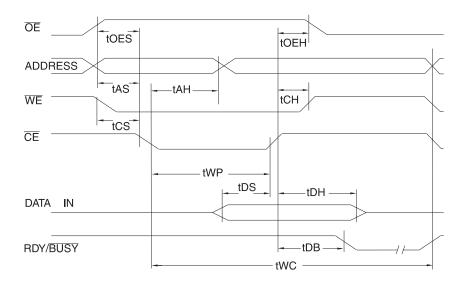
| Symbol                             | Parameter                    | Min | Max  | Units |
|------------------------------------|------------------------------|-----|------|-------|
| t <sub>AS</sub> , t <sub>OES</sub> | Address, OE Set-up Time      | 10  |      | ns    |
| t <sub>AH</sub>                    | Address Hold Time            | 100 |      | ns    |
| t <sub>WP</sub>                    | Write Pulse Width (WE or CE) | 150 | 1000 | ns    |
| t <sub>DS</sub>                    | Data Set-up Time             | 100 |      | ns    |
| t <sub>DH</sub> , t <sub>OEH</sub> | Data, OE Hold Time           | 10  |      | ns    |
| t <sub>DB</sub>                    | Time to Device Busy          |     | 50   | ns    |
| t <sub>WC</sub>                    | Write Cycle Time             |     | 3    | ms    |

### **AC Write Waveforms**

## **WE** Controlled



### **CE** Controlled



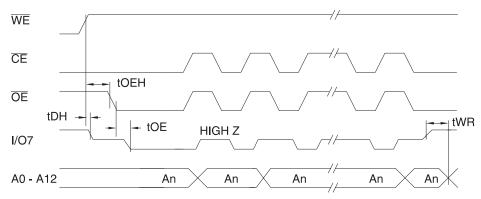
## **Data** Polling Characteristics<sup>(1)</sup>

| Symbol           | Parameter                         | Min | Тур | Max | Units |
|------------------|-----------------------------------|-----|-----|-----|-------|
| t <sub>DH</sub>  | Data Hold Time                    | 10  |     |     | ns    |
| t <sub>OEH</sub> | OE Hold Time                      | 10  |     |     | ns    |
| t <sub>OE</sub>  | ŌĒ to Output Delay <sup>(2)</sup> |     |     |     | ns    |
| t <sub>WR</sub>  | Write Recovery Time               | 0   |     |     | ns    |

Notes: 1. These parameters are characterized and not 100% tested.

2. See AC Characteristics.

## **Data Polling Waveforms**







## Ordering Information<sup>(1)</sup>

| t <sub>ACC</sub> | I <sub>CC</sub> (mA) |         | Operating    |               |         |                 |
|------------------|----------------------|---------|--------------|---------------|---------|-----------------|
| (ns)             | Active               | Standby | Voltage      | Ordering Code | Package | Operation Range |
| 300              | 8                    | 0.05    | 2.7V to 3.6V | AT28BV64-30JC | 32J     | Commercial      |
|                  |                      |         |              | AT28BV64-30PC | 28P6    | (0°C to 70°C)   |
|                  |                      |         |              | AT28BV64-30SC | 28S     |                 |
|                  |                      |         |              | AT28BV64-30SC | 28T     |                 |
|                  | 8                    | 0.05    | 2.7V to 3.6V | AT28BV64-30JI | 32J     | Industrial      |
|                  |                      |         |              | AT28BV64-30PI | 28P6    | (-40°C to 85°C) |
|                  |                      |         |              | AT28BV64-30SI | 28S     |                 |
|                  |                      |         |              | AT28BV64-30TI | 28T     |                 |

Note: 1. See Valid Part Number table below.

### **Valid Part Number**

The following table lists standard Atmel products that can be ordered.

| Device Numbers | Speed | Package and Temperature Combinations |
|----------------|-------|--------------------------------------|
| AT28BV64       | 30    | JC, JI, PC, PI, SC, SI, TC, TI       |

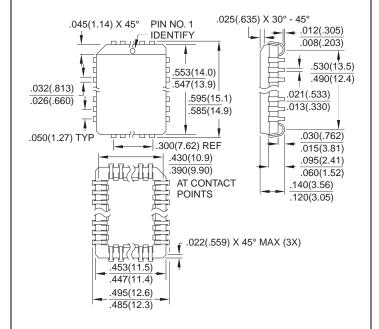
### **Die Products**

Reference Section: Parallel EEPROM Die Products

|      | Package Type   |
|------|--|
| 32J  | 32-Lead, Plastic J-Leaded Chip Carrier (PLCC)                |
| 28P6 | 28-Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)     |
| 28S  | 28-Lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC) |
| 28T  | 28-Lead, Plastic Thin Small Outline Package (TSOP)           |

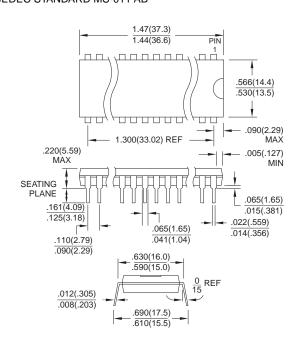
### **Packaging Information**

**32J**, 32-Lead, Plastic J-Leaded Chip Carrier (PLCC) Dimensions in Inches and (Millimeters)
JEDEC STANDARD MS-016 AE



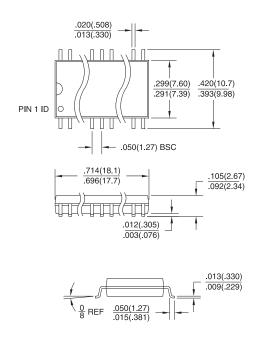
**28P6**, 28-Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)

Dimensions in Inches and (Millimeters) JEDEC STANDARD MS-011 AB



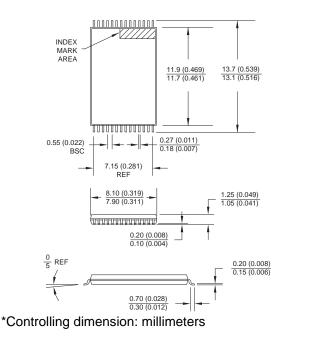
**28S**, 28-Lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC)

Dimensions in Inches and (Millimeters)



**28T**, 28-Lead, Plastic Thin Small Outline Package (TSOP)

Dimensions in Millimeters and (Inches)\*









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